

**650V N-Channel Enhancement Mode Power IGBT**

**MAIN CHARACTERISTICS**

$I_C @TC=100^\circ C$	30A
$V_{CE}$	650V
$V_{CE(sat)-typ}$	1.69V

**FEATURES**

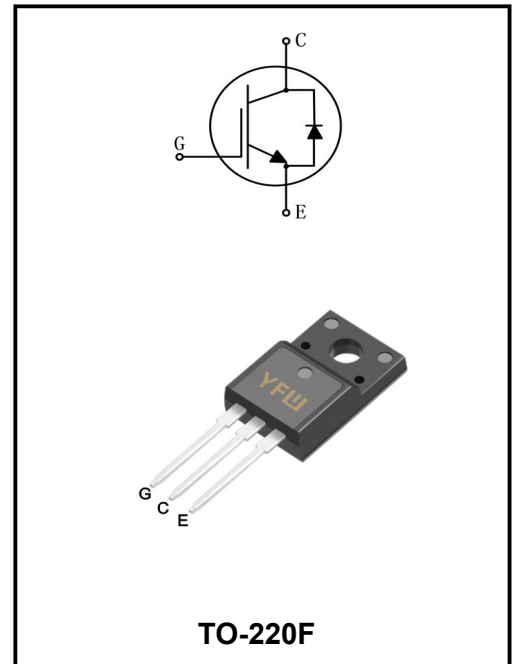
- ◆ Positive temperature coefficient
- ◆ Fast Switching
- ◆ Low  $V_{CE(sat)}$
- ◆ Reliable and Rugged
- ◆ Halogen Free and Green Devices Available

**APPLICATIONS**

- ◆ Motor drives
- ◆ Air Condition
- ◆ Inverters

**MECHANICAL DATA**

- ◆ Case: Molded plastic
- ◆ Mounting Position: Any
- ◆ Molded Plastic: UL Flammability Classification Rating 94V-0
- ◆ Lead free in compliance with EU RoHS 2011/65/EU directive
- ◆ Solder bath temperature 275°C maximum, 10s per JESD 22-B106



**Maximum Ratings**

Characteristics	Symbol	Value	Unit
Collector-emitter voltage	$V_{CES}$	650	V
Gate-emitter voltage	$V_{GES}$	±30	V
Continuous collector current (TC=25°C)	$I_C$	60	A
Continuous collector current (TC=100°C)		30	A
Pulsed collector current, tp limited by Tvjmax	$I_{CM}$	90	A
Diode continuous forward current (TC=25°C)	$I_F$	60	A
Diode continuous forward current (TC=100°C)		30	A
Diode maximum current, tp limited by Tvjmax	$I_{FM}$	90	A
Operating junction temperature range	$T_{vj}$	-55 to +175	°C
Storage temperature range	$T_{stg}$	-55 to +175	°C

**Thermal characteristics**

Characteristics	Symbol	Values		Unit
		Typ	Max.	
Thermal resistance, junction to case for IGBT	$R_{th(j-c)}$	-	0.83	K/ W
Thermal resistance, junction to case for Diode	$R_{th(j-c)}$	-	0.65	K/ W
Thermal resistance, junction to ambient	$R_{th(j-a)}$	-	40	K/ W

**Note1:Pulse test: 300  $\mu$ s pulse width, 2 % duty cycle**
**Electrical characteristics of IGBT at  $T_{vj}=25^{\circ}\text{C}$  unless otherwise specified**

Characteristics	Test Condition	Symbol	Min	Typ	Max	Unit
Collector-emitter breakdown voltage	$V_{GE}=0\text{V}, I_c=250\mu\text{A}$	$B_{V_{CES}}$	650	-	-	V
Collector-emitter leakage current	$V_{CE}=650\text{V}, V_{GE}=0\text{V}$	$I_{CES}$	-	-	10	$\mu\text{A}$
Gate leakage current, forward	$V_{GE}=\pm 20\text{V}, V_{CE}=0\text{V}$	$I_{GES}$	-	-	$\pm 200$	nA
Gate-emitter threshold voltage	$V_{GE}=V_{CE}, I_c=1\text{mA}$	$V_{GE(th)}$	4.3	5.3	6.3	V
Collector-emitter saturation voltage	$V_{GE}=15\text{V}, I_c=30\text{A}$	$V_{CE(sat)}$	-	1.69	2	V
	$V_{GE}=15\text{V}, I_c=30\text{A}, T_{vj}=125^{\circ}\text{C}$		-	1.9	-	V
	$V_{GE}=15\text{V}, I_c=30\text{A}, T_{vj}=175^{\circ}\text{C}$		-	2.05	-	V
Input capacitance	$V_{CE}=25\text{V}$ $V_{GE}=0\text{V}$ $f=1\text{MHz}$	$C_{ies}$	-	1853	-	pF
Output capacitance		$C_{oes}$	-	72	-	pF
Reverse transfer capacitance		$C_{res}$	-	55	-	pF
Total gate charge		$Q_g$	-	98	-	nC
Gate- Emitter Charge	$V_{CC}=520\text{V } V_{GE}=15\text{V } I_c=30\text{A}$	$Q_{ge}$	-	18	-	nC
Gate- Collector Charge		$Q_{gc}$	-	47	-	nC
Short circuit collector current	$V_{GE}=15\text{V}, V_{CC}\leq 400\text{V } T_{J}\leq 175^{\circ}\text{C}$	$t(SC)$	-	8	-	$\mu\text{s}$
Max.1000 short circuits, times			-		-	
Between short circuits: $\geq 1.0\text{s}$			-		-	
Turn-on delay time	$V_{CC}=400\text{V}$ $V_{GE}=15\text{V}$ $I_c=30\text{A}$ $R_G=5\Omega$ Inductive load	$t_d(on)$	-	16	-	ns
Rise time		$t_r$	-	46	-	ns
Turn-off delay time		$t_d(off)$	-	72	-	ns
Fall time		$t_f$	-	80	-	ns
Turn-on energy		$E_{on}$	-	0.52	-	mJ
Turn-off energy		$E_{off}$	-	0.77	-	mJ
Total switching energy		$E_{ts}$	-	1.29	-	mJ
Turn-on delay time		$V_{CC}=400\text{V}$ $V_{GE}=15\text{V}$ $I_c=30\text{A}$ $R_G=5\Omega$ Inductive load $T_{vj}=175^{\circ}\text{C}$	$t_d(on)$	-	18	-
Rise time	$t_r$		-	54	-	ns
Turn-off delay time	$t_d(off)$		-	90	-	ns
Fall time	$t_f$		-	75	-	ns
Turn-on energy	$E_{on}$		-	0.97	-	mJ
Turn-off energy	$E_{off}$		-	1.36	-	mJ
Total switching energy	$E_{ts}$		-	2.33	-	mJ
Diode forward voltage	$I_F=30\text{A}$		$VF$	-	2	2.3
	$I_F=30\text{A } T_{vj}=125^{\circ}\text{C}$	-		1.7	-	V
	$I_F=30\text{A } T_{vj}=175^{\circ}\text{C}$	-		1.5	-	V

Diode reverse recovery time	$I_F=30A$ $diF/dt=-200A/\mu s$	<b>trr</b>	-	48	-	<b>ns</b>
Diode peak reverse recovery current		<b>Qrr</b>	-	80	-	<b>nC</b>
Diode reverse recovery charge		<b>Irrm</b>	-	5.1	-	<b>A</b>
Diode reverse recovery time	$I_F=30A$ $diF/dt=-200A/\mu s$ $T_{vj}=175^{\circ}C$	<b>trr</b>	-	39	-	<b>ns</b>
Diode peak reverse recovery current		<b>Qrr</b>	-	127	-	<b>nC</b>
Diode reverse recovery charge		<b>Irrm</b>	-	8.5	-	<b>A</b>

Figure 1: Power Dissipation

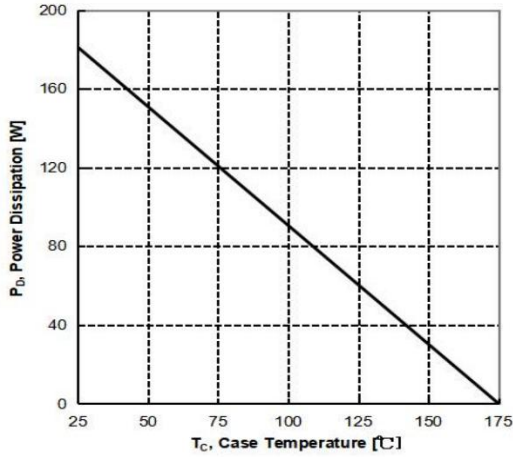


Figure 2: Collector Current vs. Case Temperature

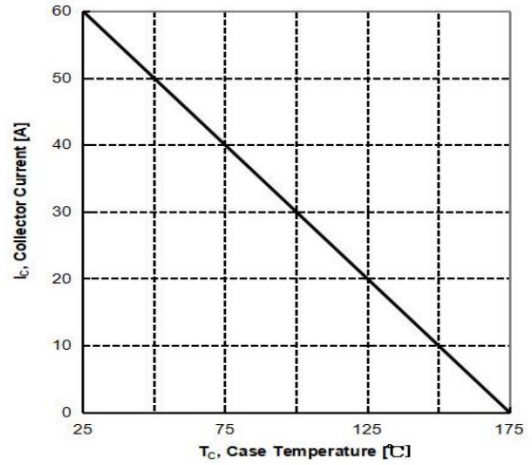


Figure 3: Safe Operation Area

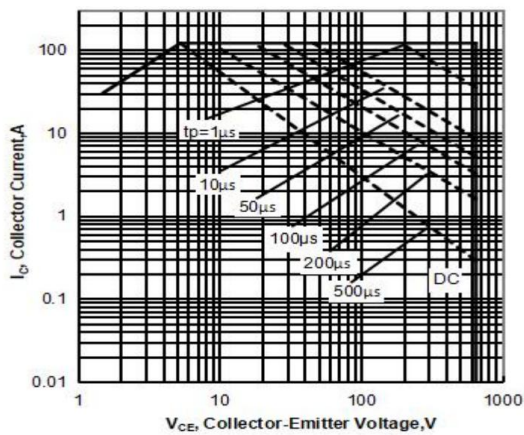


Figure 4: Typical Transfer Characteristics

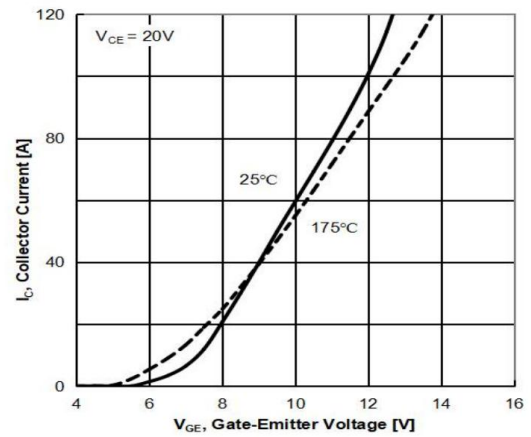


Figure 5: Typical Output Characteristics

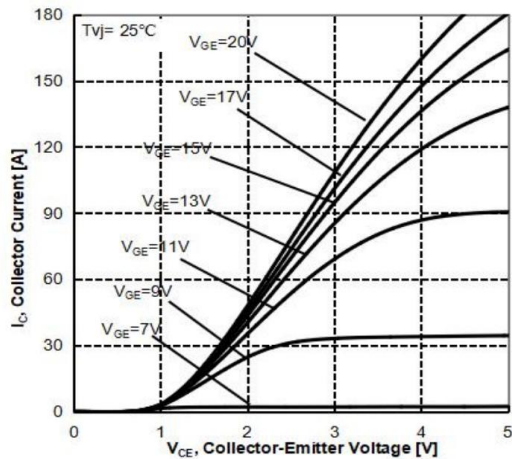
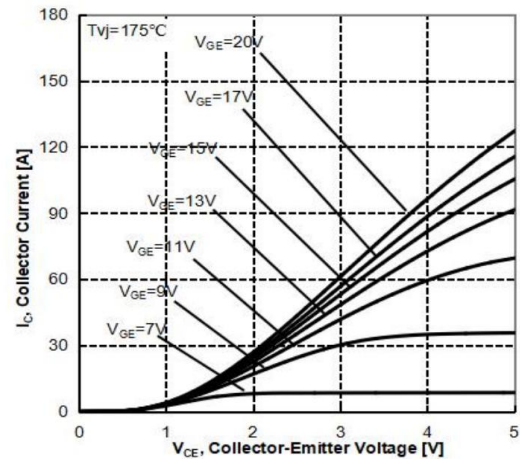
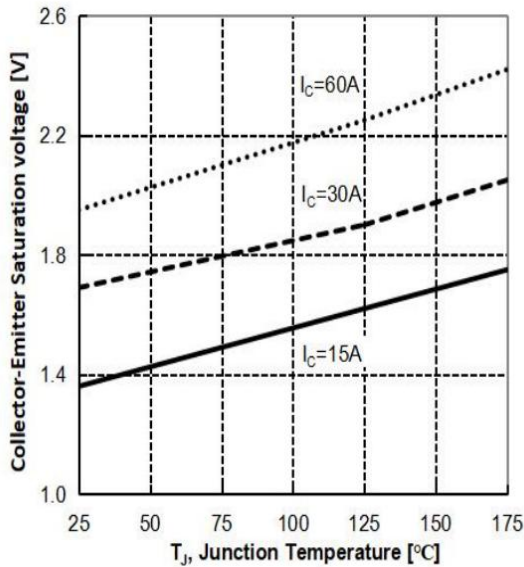


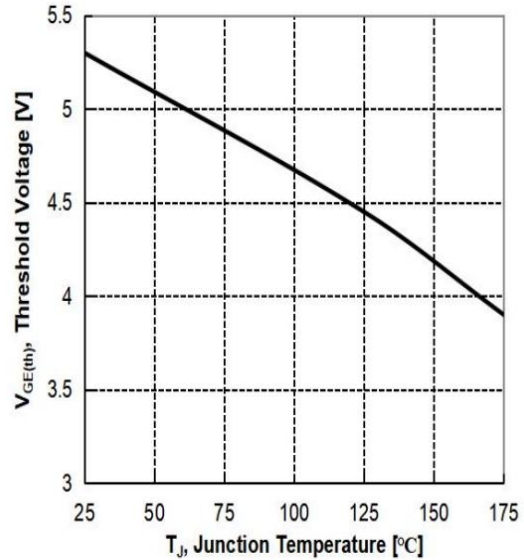
Figure 6: Typical Output Characteristics



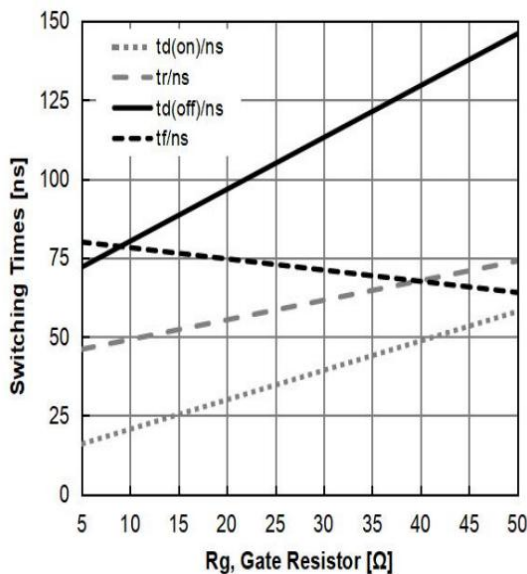
**Figure 7: Typical Collector-Emitter Saturation Voltage vs. Junction Temperature**



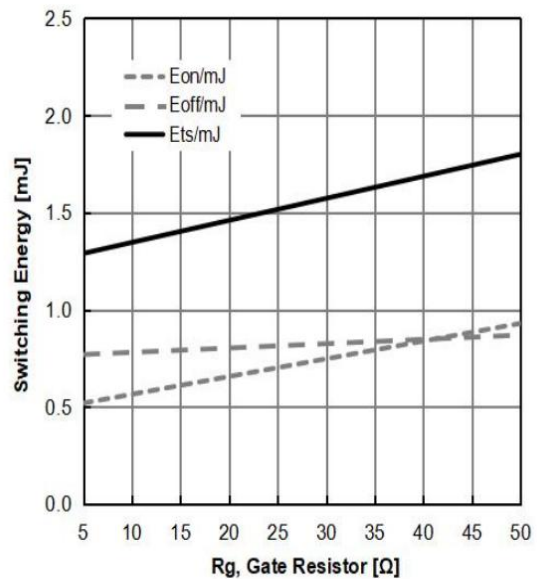
**Figure 8: Typical Gate-Emitter Threshold Voltage vs. Junction Temperature**



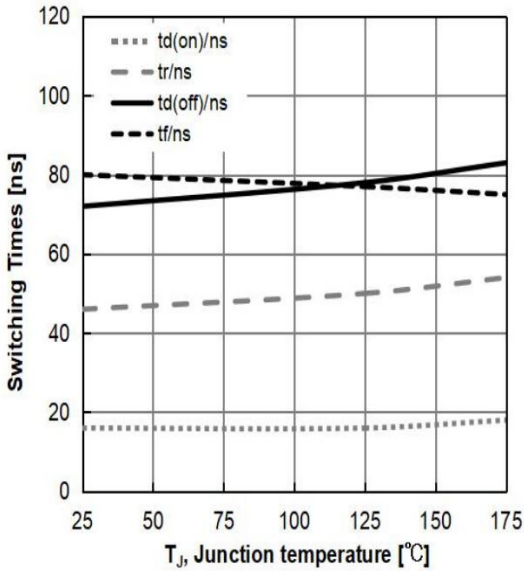
**Figure 9: Typical Switching Times vs. Gate Resistor (T<sub>J</sub>=25°C, V<sub>CE</sub>=400V, V<sub>GE</sub>=15/0V, I<sub>C</sub>=30A)**



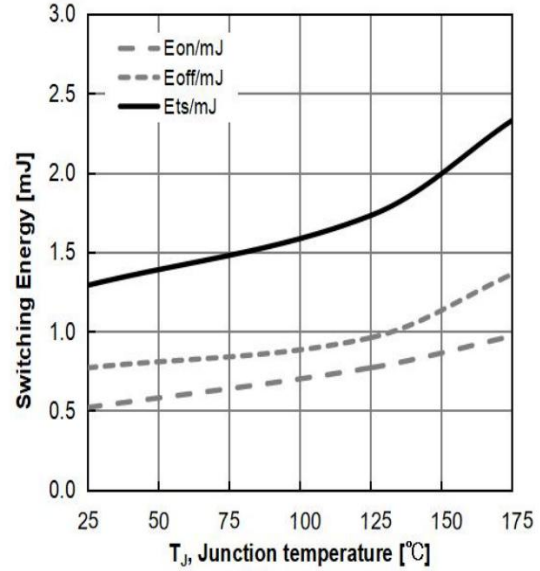
**Figure 10: Typical Switching Energy vs. Gate Resistor (T<sub>J</sub>=25°C, V<sub>CE</sub>=400V, V<sub>GE</sub>=15/0V, I<sub>C</sub>=30A)**



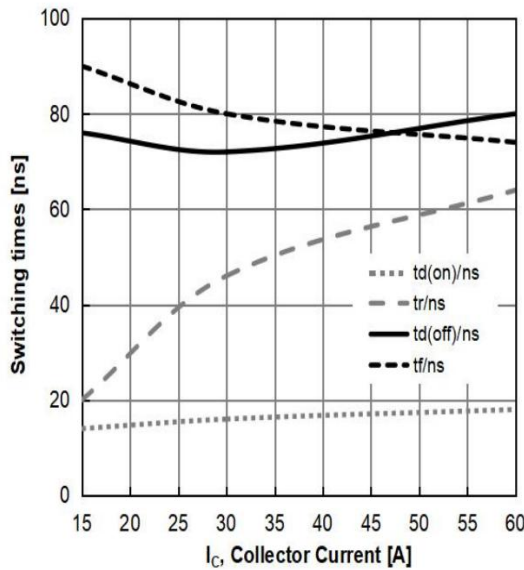
**Figure 11: Typical Switching Times vs. Junction Temperature ( $V_{CE}=400V$ ,  $V_{GE}=15/0V$ ,  $I_C=30A$ )**



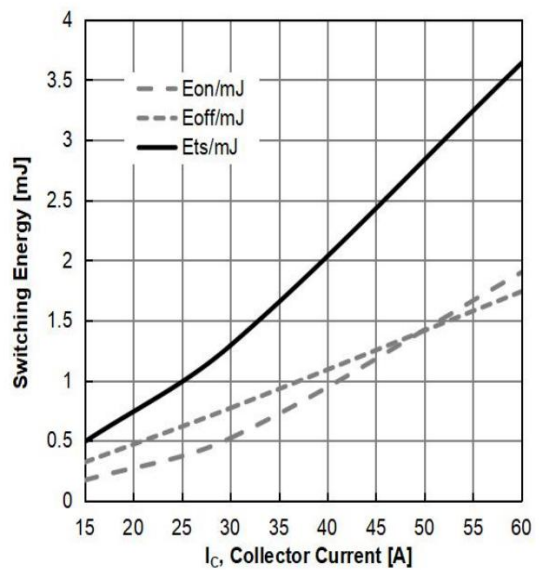
**Figure 12: Typical Switching Energy vs. Junction Temperature ( $V_{CE}=400V$ ,  $V_{GE}=15/0V$ ,  $I_C=30A$ )**



**Figure 13: Typical Switching Times vs. Collector Current ( $T_J=25^\circ C$ ,  $V_{CE}=400V$ ,  $V_{GE}=15/0V$ )**



**Figure 14: Typical Switching Energy vs. Collector Current ( $T_J=25^\circ C$ ,  $V_{CE}=400V$ ,  $V_{GE}=15/0V$ )**



RATINGS AND CHARACTERISTIC CURVES

Figure 19: IGBT Transient Thermal Impedance vs. Pulse Width

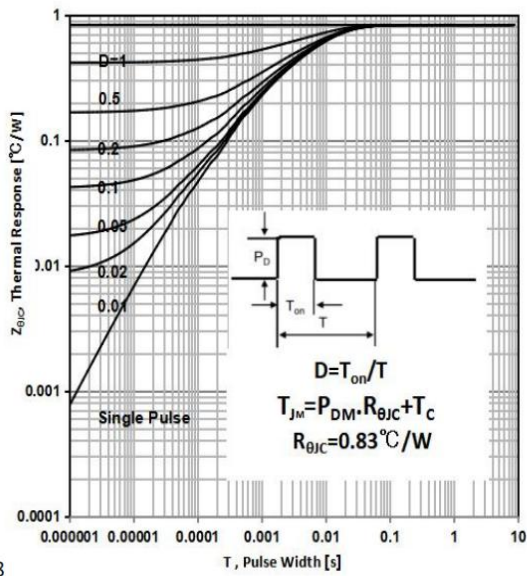


Figure 20: Diode Transient Thermal Impedance vs. Pulse Width

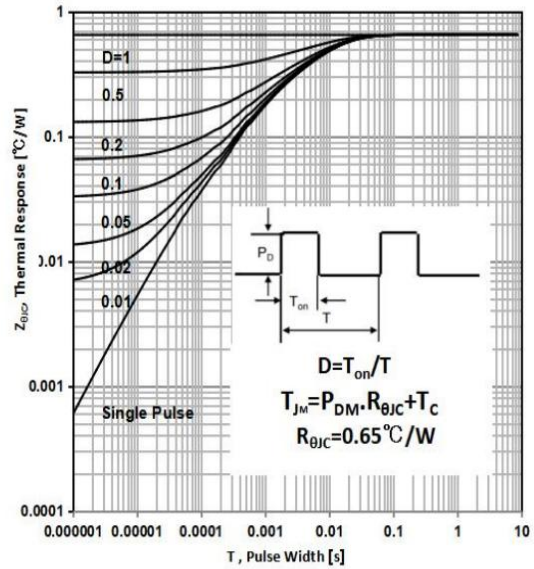
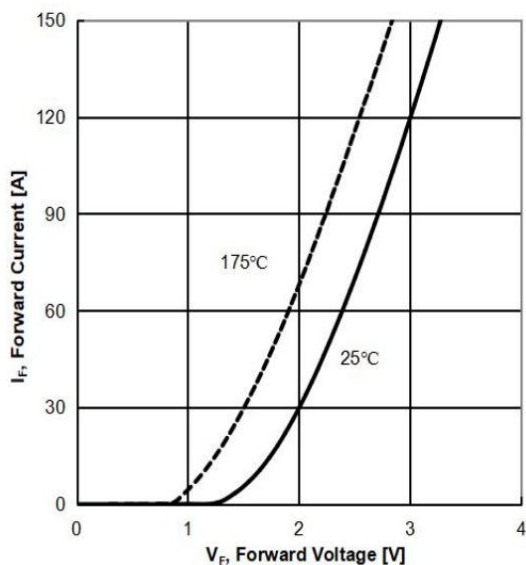
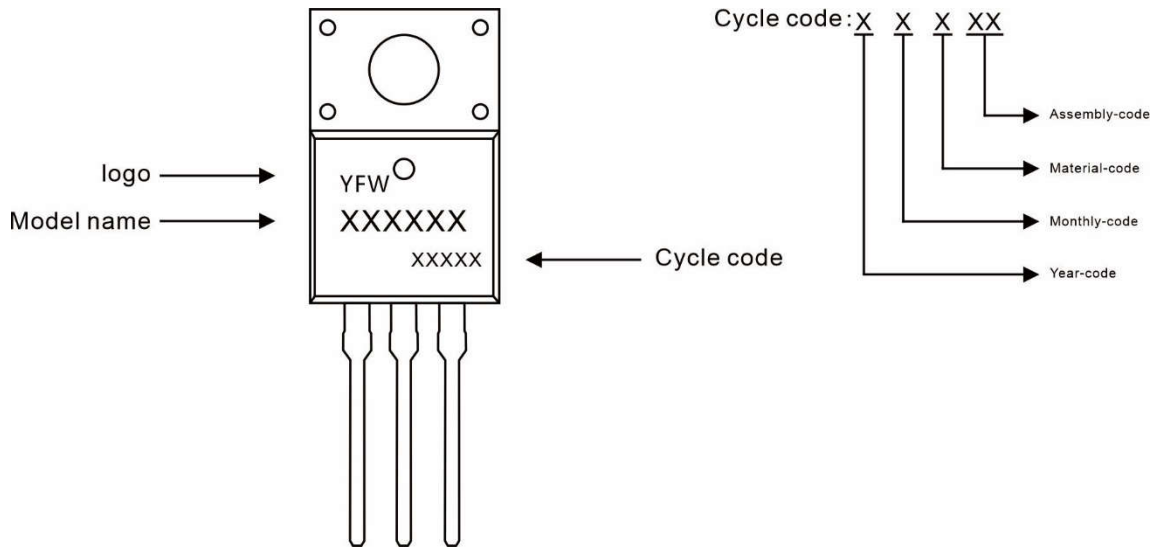


Figure 21: Typical Diode Forward Current vs. Forward Voltage



**Marking Diagram**



**Ordering information**

Model name	Package	Unit Weight	Base Quantity	Packing Quantity
YFWG30T65HAF	TO-220F	0.06oz(1.74g)	50pcs/tube	1000PCS/Box 5000PCS/Carton

**Package Dimensions**

**TO-220F**

Symbol	Millimeter		Inches	
	Min.	Max.	Min.	Max.
A	4.50	4.90	0.177	0.193
A1	2.34	2.74	0.092	0.108
A2	2.66	2.86	0.105	0.113
b	0.75	0.85	0.030	0.033
b1	1.24	1.44	0.049	0.057
c	0.40	0.60	0.016	0.024
D	10.00	10.32	0.394	0.406
E	15.75	16.05	0.620	0.632
e	2.44	2.64	0.096	0.104
e1	4.88	5.28	0.192	0.208
F	3.10	3.5	0.122	0.138
L	13.50	13.90	0.531	0.547
L1	2.90	3.30	0.114	0.130
Φ	3.10	3.30	0.122	0.130



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